MOSFET - N-Channel, SUPERFET® II, FRFET®

650 V, 76 A, 41 m Ω

FCH041N65F

Description

SUPERFET II MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SUPERFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. SUPERFET II FRFET MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.

Features

- $700 \text{ V} @ \text{T}_{\text{J}} = 150^{\circ}\text{C}$
- Typ. $R_{DS(on)} = 36 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q_g = 226 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 1278 pF)
- 100% Avalanche Tested
- This Device is Pb-Free and is RoHS Compliant

Applications

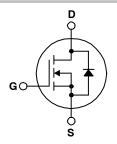
- LCD, LED, PDP TV
- Solar Inverter
- Telecom, Server Power Supplies
- AC-DC Power Supply



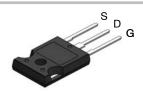
ON Semiconductor®

www.onsemi.com

V _{DS}	R _{DS(ON)} MAX	I _D MAX
650 V	41 mΩ @ 10 V	76 A

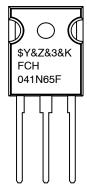


N-CHANNEL MOSFET



TO-247-3LD CASE 340CH

MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code &K = Lot Code FCH041N65F = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter		FCH041N65F-F155	Unit
V_{DSS}	Drain to Source Voltage	650	V	
V_{GSS}	Gate to Source Voltage	-DC		V
		-AC (f > 1 Hz)	±30	
I _D	Drain Current	nt –Continuous (T _C = 25°C)		Α
		–Continuous (T _C = 100°C)	48.1	
I _{DM}	Drain Current	-Pulsed (Note 1)	228	Α
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		2025	mJ
I _{AR}	Avalanche Current (Note 1)		15	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)		5.95	mJ
dv/dt	MOSFET dv/dt		100	V/ns
	Peak Diode Recovery dv/dt (Note 3)		50	
P_{D}	Power Dissipation	Power Dissipation $(T_C = 25^{\circ}C)$		W
		-Derate Above 25°C	4.76	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to + 150	°C
TL	Maximum Lead Temperature for Soldering, % from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality shesses exceeding those listed in the Maximum Hallings table may damage it should not be assumed, damage may occur and reliability may be affected.

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. $I_{AS} = 15 \text{ A}$, $R_G = 25 \Omega$, Starting $T_J = 25^{\circ}C$ 3. $I_{SD} \le 38 \text{ A}$, $di/dt \le 200 \text{ A/}\mu\text{s}$, $V_{DD} \le 380 \text{ V}$, Starting $T_J = 25^{\circ}C$.

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCH041N65F-F155	FCH041N65F	TO-247-3LD	Tube	N/A	N/A	30 Units

THERMAL CHARACTERISTICS

ſ	Symbol	Parameter	FCH041N65F-F155	Unit
Ī	$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.21	°C/W
Ī	$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARA	ACTERISTICS		•			
BV _{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V, I}_{D} = 10 \text{ mA, T}_{J} = 25^{\circ}\text{C}$	650	-	_	V
		V _{GS} = 0 V, I _D = 10 mA, T _J = 150°C	700	_	-	
$\Delta BV_{DSS}/ \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, Referenced to 25°C	-	0.72	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650 V, V _{GS} = 0 V	-	-	10	μΑ
		V _{DS} = 520 V, T _C = 125°C	-	232	-	
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA
ON CHARA	CTERISTICS		•			
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 7.6 \text{ mA}$	3	_	5	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 38 A	-	36	41	mΩ
9FS	Forward Transconductance	V _{DS} = 20 V, I _D = 38 A	-	18	-	S
OYNAMIC C	HARACTERISTICS		•	•		
C _{iss}	Input Capacitance	V _{DS} = 100 V, V _{GS} = 0 V,	-	9790	13020	pF
C _{oss}	Output Capacitance	f = 1 MHz	_	355	470	pF
C _{rss}	Reverse Transfer Capacitance		-	32	-	pF
C _{oss}	Output Capacitance	V _{DS} = 380 V, V _{GS} = 0 V, f = 1 MHz	-	192	-	pF
C _{oss(eff.)}	Effective Output Capacitance	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	1278	-	pF
Q _{g(tot)}	Total Gate Charge at 10 V	V _{DD} = 380 V, I _D = 38 A,	-	226	294	nC
Q _{gs}	Gate to Source Gate Charge	V _{GS} = 10 V (Note 4)	-	50	-	nC
Q _{gd}	Gate to Drain "Miller"Charge	(1010 1)	_	90	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	0.6	-	Ω
SWITCHING	CHARACTERISTICS		•	•		
t _{d(on)}	Turn-On Delay Time	V _{DD} = 380 V, I _D = 38 A,	-	60	130	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{G} = 4.7 \Omega$ (Note 4)	-	47	104	ns
t _{d(off)}	Turn-Off Delay Time	(Note 4)	-	190	390	ns
t _f	Turn-Off Fall Time		_	6.5	23	ns
DRAIN-SOU	RCE DIODE CHARACTERISTICS		•	•		
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	76	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	228	Α
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 38 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 38 A,	-	213	-	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/μs	_	1.3	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS

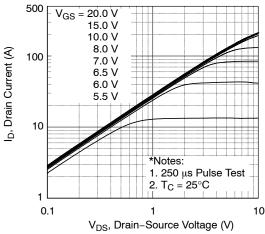


Figure 1. On-Region Characteristics

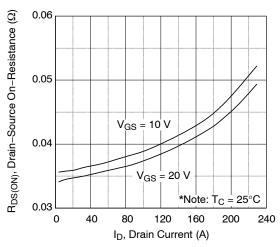


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

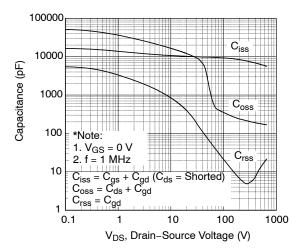


Figure 5. Capacitance Characteristics

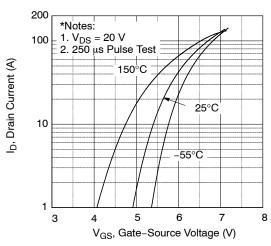


Figure 2. Transfer Characteristics

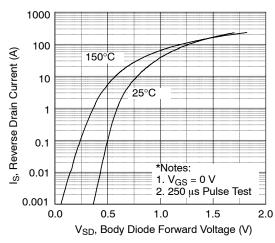


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

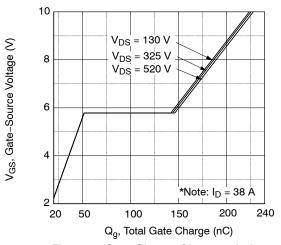


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

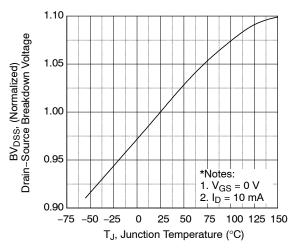


Figure 7. Breakdown Voltage Variation vs. Temperature

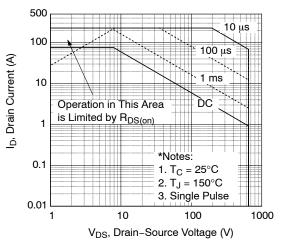


Figure 9. Maximum Safe Operating Area

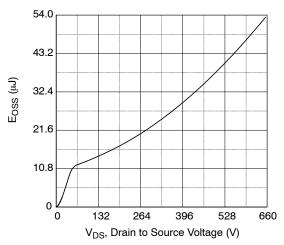


Figure 11. E_{OSS} vs. Drain to Source Voltage

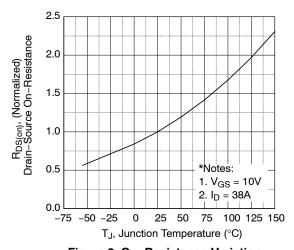


Figure 8. On-Resistance Variation vs. Temperature

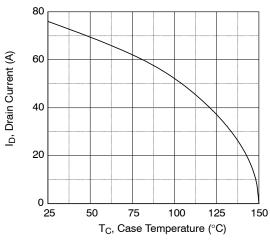


Figure 10. Maximum Drain Current vs. Case Temperature

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

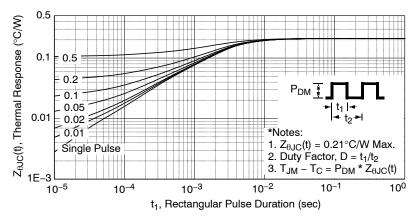


Figure 12. Transient Thermal Response Curve

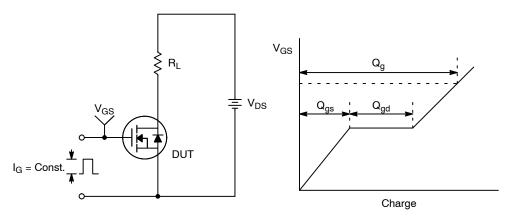


Figure 13. Gate Charge Test Circuit & Waveform

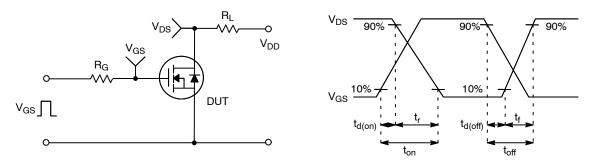


Figure 14. Resistive Switching Test Circuit & Waveforms

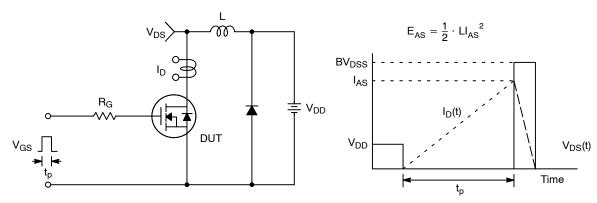


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

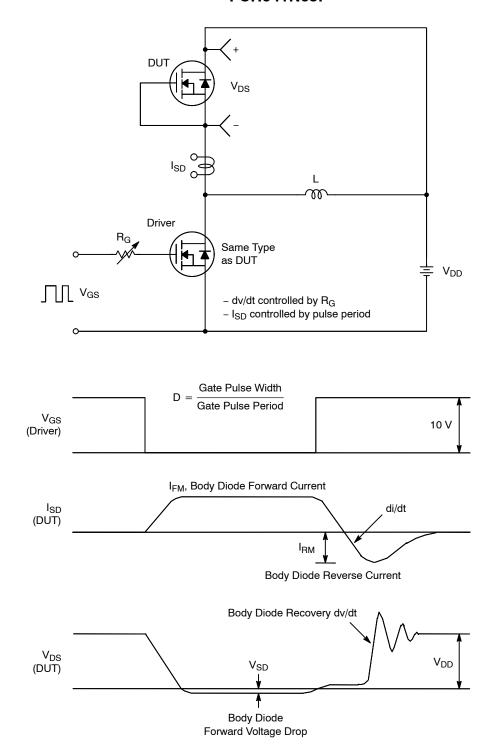
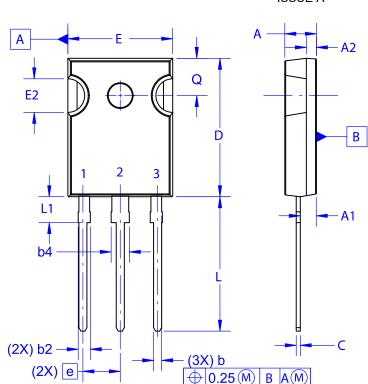


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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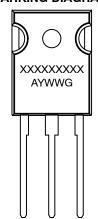
TO-247-3LD CASE 340CH **ISSUE A**





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
 D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC **MARKING DIAGRAM***



XXXX = Specific Device Code

= Assembly Location

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

	D	ATE 0	9 OCT 201	9
Ø P —			ØP1 D2	
S = E1 -)	D1	
	2			
'			9	

DIM	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	4.58	4.70	4.82	
A 1	2.29	2.475	2.66	
A2	1.40	1.50	1.60	
D	20.32	20.57	20.82	
Е	15.37	15.62	15.87	
E2	4.96	5.08	5.20	
е	~	5.56	~	
L	19.75	20.00	20.25	
L1	3.69	3.81	3.93	
ØΡ	3.51	3.58	3.65	
Q	5.34	5.46	5.58	
S	5.34	5.46	5.58	
b	1.17	1.26	1.35	
b2	1.53	1.65	1.77	
b4	2.42	2.54	2.66	
С	0.51	0.61	0.71	
D1	13.08	~	~	
D2	0.51	0.93	1.35	
E1	12.81	~	~	
ØP1	6.61	6.73	6.85	

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DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1	

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